

GSC4410

N-CHANNEL ENHANCEMENT MODE POWER MOSFET

BVDSS	30V
RDS(ON)	13.5mΩ
ID	10A

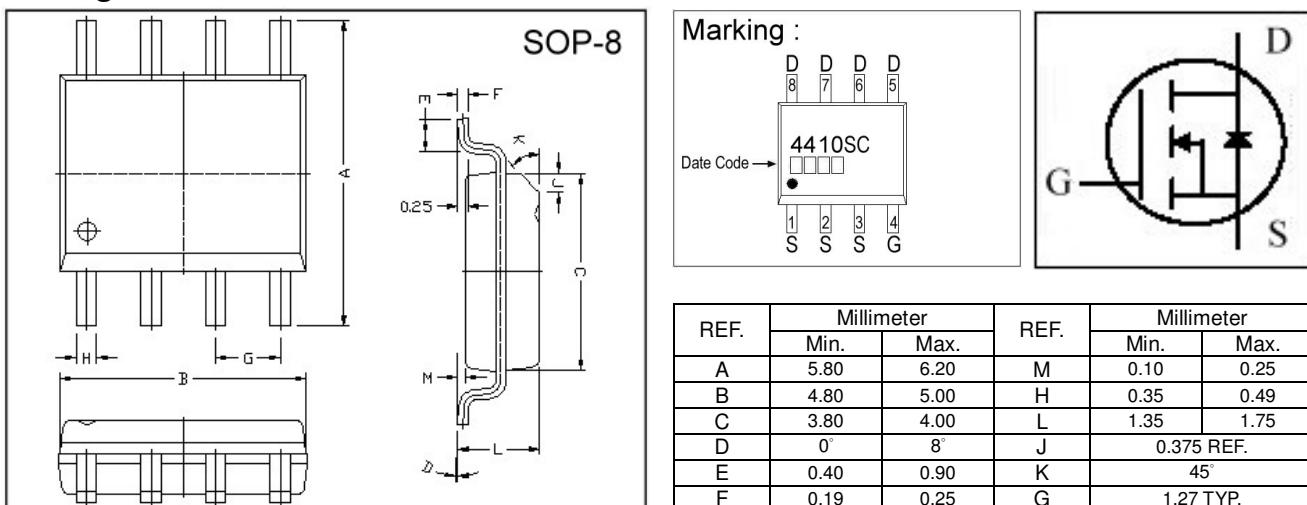
Description

The GSC4410 provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SOP-8 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

Features

- *Dynamic dv/dt Rating
- *Simple Drive Requirement
- *Repetitive Avalanche Rated
- *Fast Switching

Package Dimensions**Absolute Maximum Ratings**

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current, V _{GS} @10V	I _D @TA=25°C	10	A
Continuous Drain Current, V _{GS} @10V	I _D @TA=70°C	8	A
Pulsed Drain Current ¹	I _{DM}	50	A
Total Power Dissipation	P _D @TA=25°C	2.5	W
Linear Derating Factor		0.02	W/°C
Operating Junction and Storage Temperature Range	T _j , T _{stg}	-55 ~ +150	°C

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-ambient Max.	R _{thj-amb}	50	°C/W

Electrical Characteristics($T_j = 25^\circ\text{C}$ Unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	30	-	-	V	$\text{V}_{\text{GS}}=0$, $\text{I}_D=250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}} / \Delta T_j$	-	0.037	-	V/ $^\circ\text{C}$	Reference to 25°C , $\text{I}_D=1\text{mA}$
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	1.0	-	3.0	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}$, $\text{I}_D=250\mu\text{A}$
Forward Transconductance	g_{fs}	-	20	-	S	$\text{V}_{\text{DS}}=15\text{V}$, $\text{I}_D=10\text{A}$
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$\text{V}_{\text{GS}}= \pm 20\text{V}$
Drain-Source Leakage Current($T_j=25^\circ\text{C}$)	I_{DSS}	-	-	1	uA	$\text{V}_{\text{DS}}=30\text{V}$, $\text{V}_{\text{GS}}=0$
Drain-Source Leakage Current($T_j=55^\circ\text{C}$)		-	-	25	uA	$\text{V}_{\text{DS}}=24\text{V}$, $\text{V}_{\text{GS}}=0$
Static Drain-Source On-Resistance	$\text{R}_{\text{DS}(\text{ON})}$	-	11.5	13.5	$\text{m}\Omega$	$\text{V}_{\text{GS}}=10\text{V}$, $\text{I}_D=10\text{A}$
		-	16.5	20		$\text{V}_{\text{GS}}=4.5\text{V}$, $\text{I}_D=5\text{A}$
Total Gate Charge ²	Q_g	-	20	-	nC	$\text{I}_D=10\text{A}$ $\text{V}_{\text{DS}}=15\text{V}$ $\text{V}_{\text{GS}}=5\text{V}$
Gate-Source Charge	Q_{gs}	-	3	-		
Gate-Drain ("Miller") Change	Q_{gd}	-	11	-		
Turn-on Delay Time ²	$\text{T}_{\text{d}(\text{on})}$	-	7.5	-	ns	$\text{V}_{\text{DS}}=25\text{V}$ $\text{I}_D=1\text{A}$ $\text{V}_{\text{GS}}=5\text{V}$ $\text{R}_G=3.3\Omega$ $\text{R}_D=25\Omega$
Rise Time	T_r	-	10.2	-		
Turn-off Delay Time	$\text{T}_{\text{d}(\text{off})}$	-	29	-		
Fall Time	T_f	-	33	-		
Input Capacitance	C_{iss}	-	955	-	pF	$\text{V}_{\text{GS}}=0\text{V}$ $\text{V}_{\text{DS}}=15\text{V}$ $f=1.0\text{MHz}$
Output Capacitance	C_{oss}	-	555	-		
Reverse Transfer Capacitance	C_{rss}	-	204	-		

Source-Drain Diode

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage ²	V_{SD}	-	-	1.3	V	$\text{I}_S=2.3\text{A}$, $\text{V}_{\text{GS}}=0\text{V}$, $T_j=25^\circ\text{C}$
Continuous Source Current (Body Diode)	I_S	-	-	2.3	A	$\text{V}_D=\text{V}_G=0\text{V}$, $\text{V}_S=1.3\text{V}$
Pulsed Source Current (Body Diode) ¹	I_{SM}	-	-	50	A	

Notes: 1. Pulse width limited by safe operating area.

2. Pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.

Characteristics Curve

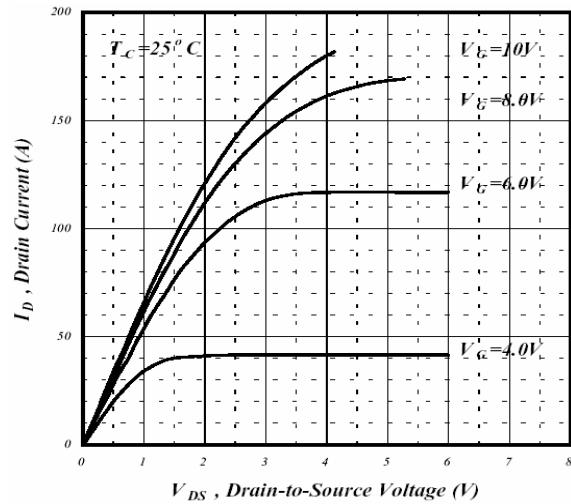


Fig 1. Typical Output Characteristics

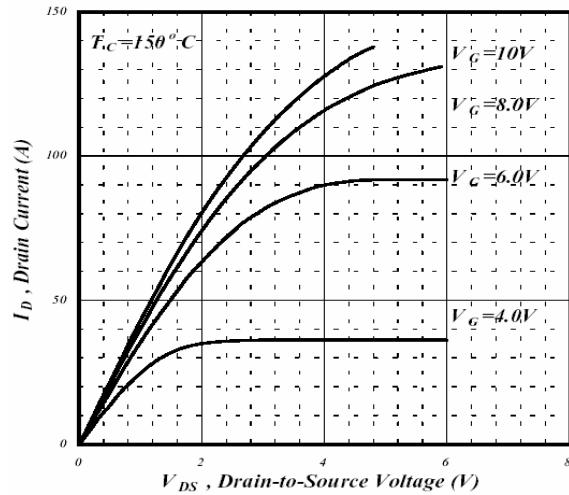


Fig 2. Typical Output Characteristics

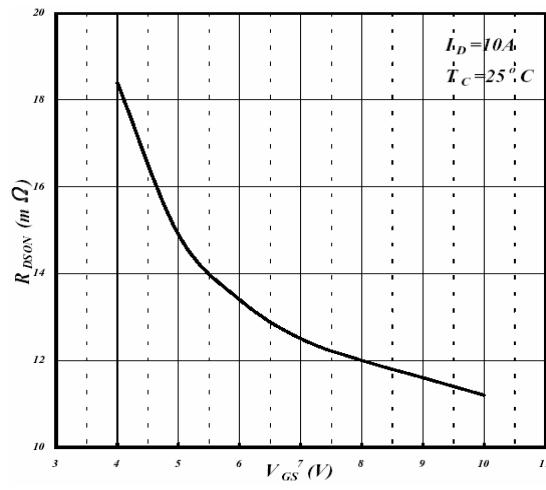


Fig 3. On-Resistance v.s. Gate Voltage

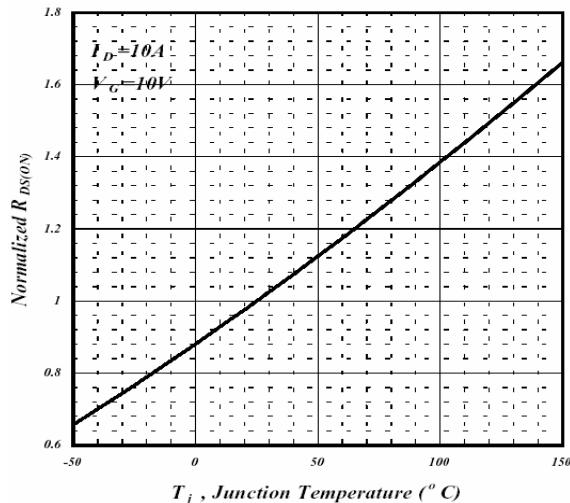


Fig 4. Normalized On-Resistance v.s. Junction Temperature

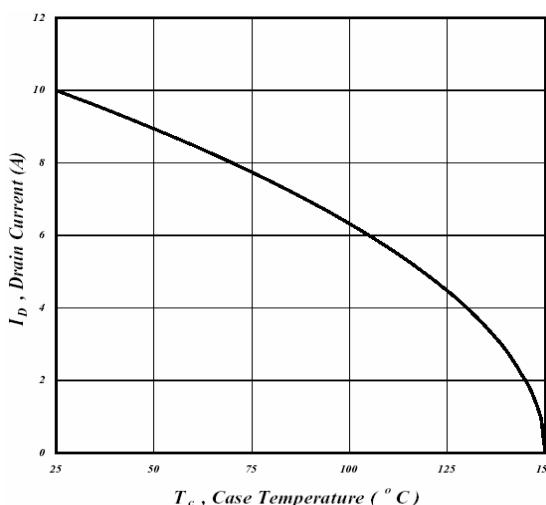


Fig 5. Maximum Drain Current v.s. Case Temperature

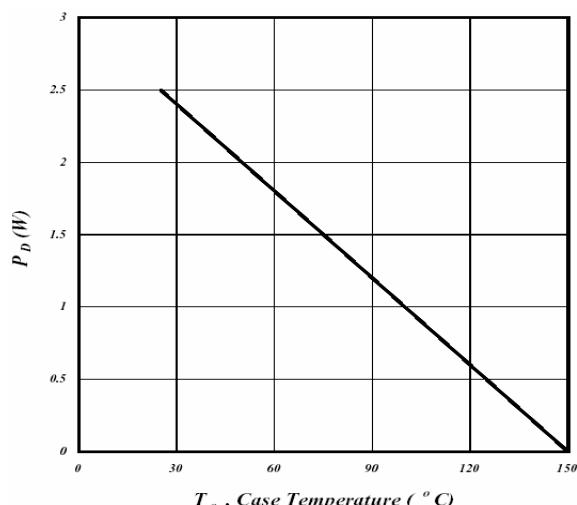
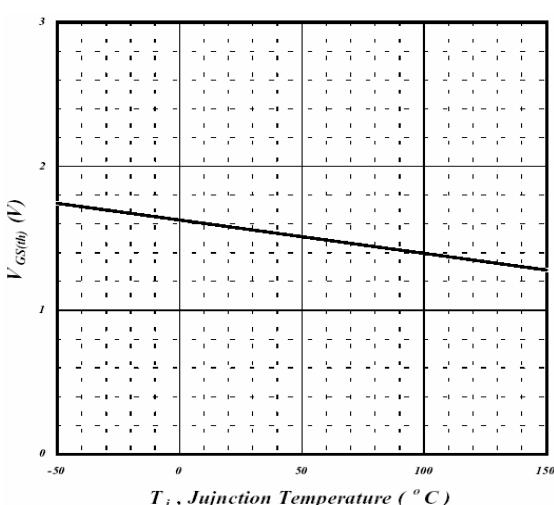
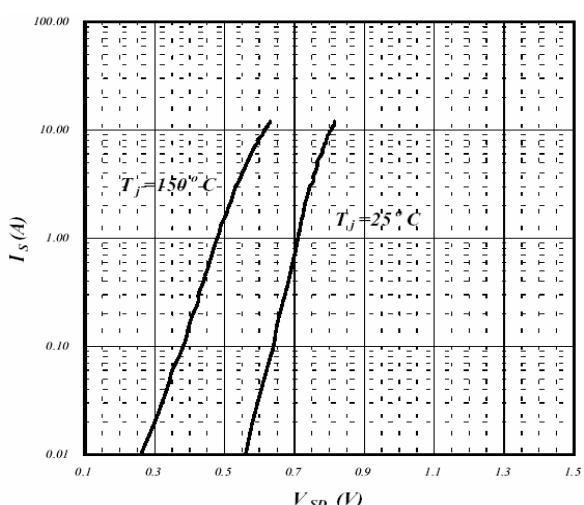
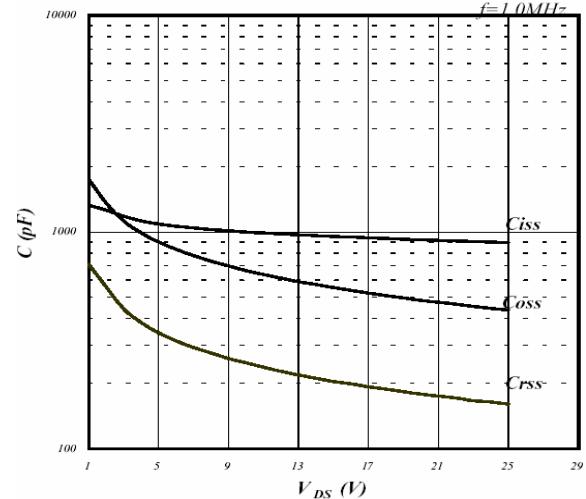
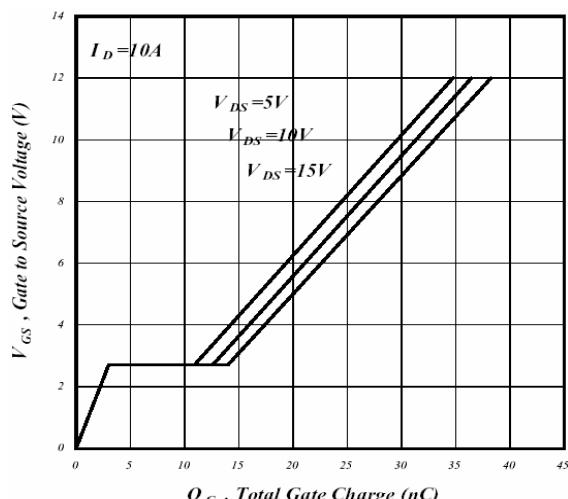
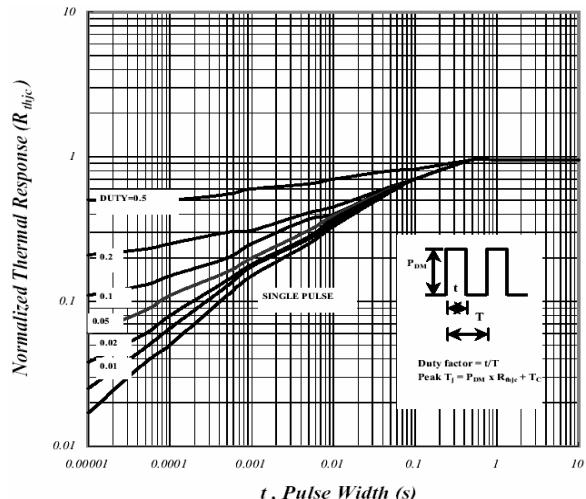
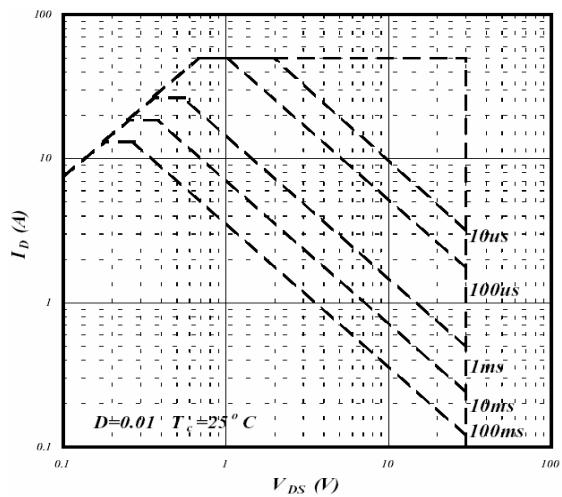


Fig 6. Type Power Dissipation



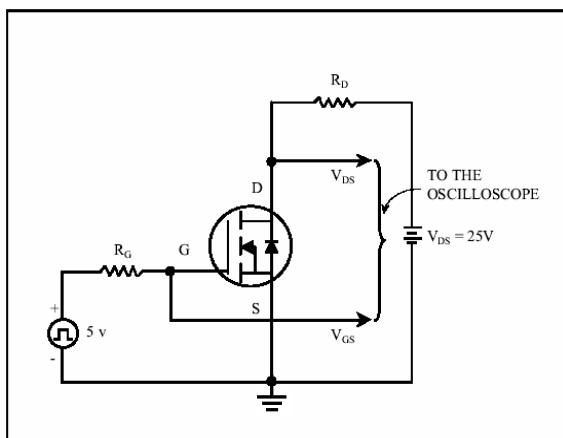


Fig 13. Switching Time Circuit

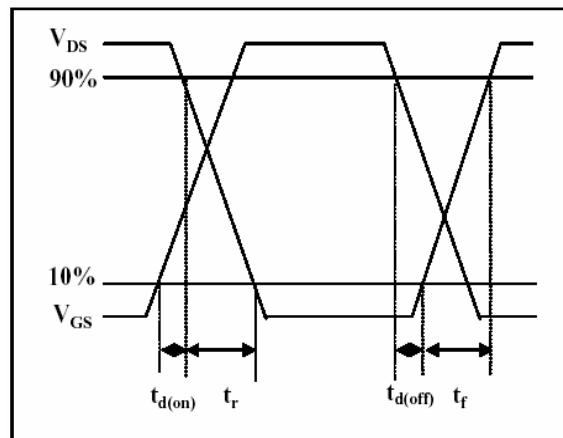


Fig 14. Switching Time Waveform

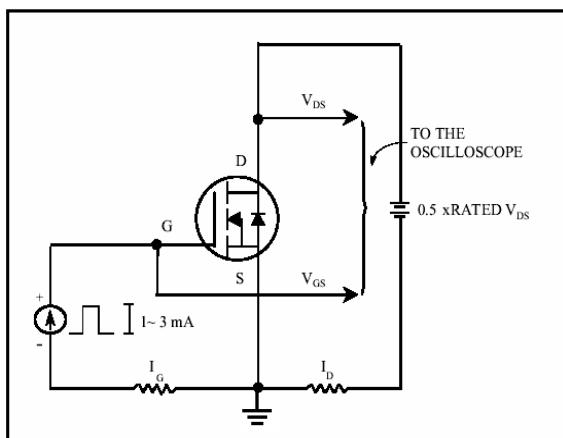


Fig 15. Gate Charge Circuit

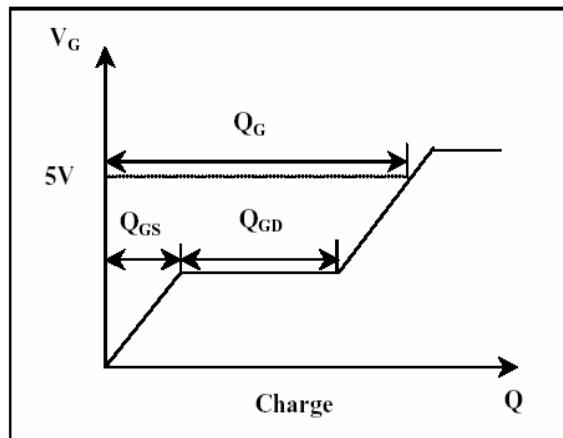


Fig 16. Gate Charge Waveform

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